PCN Number:	20140930001							<b>PCN Date:</b> 10/03		
Title: Datashee family of		s, Die rev	vision,	and	Mount Compou	ınd C	Change fo	or UCI	)3138064	
<b>Customer Contac</b>	ct: PCN A	<u>Manager</u>	Pho	ne:	+1(214)480-6	5037	Dept:	Qu	ality Services	
		01/01/2	/ /					provided at ple request		
Change Type:		l							1	
Assembly Site			Desi	ign			Wafe	r Bum	np Site	
Assembly Prod	cess		✓ Data Sheet			Wafer Bump Material				
Assembly Mat	erials		Part	Part number change				Wafer Bump Process		
Mechanical Specification			Test Site			Wafer Fab Site				
Packing/Shipp	ing/Labeli	ing	Test	Test Process			Wafer Fab Materials			
							Wafer Fab Process			
			PO	CN	Details					
<b>Description of Ch</b>	nange:									
Texas Instruments few datasheet cha									es will undergo a	
	Pkg		From		То					
	Die Rev		A3			A4				
	Mount Compou				4207123					
	Trounc C	zompoun	u	120	7700	-120	77123			
Datasheet Change	s:									
Changes from Revision A (February 2014) to Revision B Page										
Functional Mode section, Device a section	s, Application and Document	and Implentation Suppo	nentation s ort section	section, and	g Rating table, Featur on, Power Supply Red I Mechanical, Packag	comme ing, ai	endations se nd Orderable	ection, La e Inform	ayout ation <u>1</u>	
The datasheet nun	nber will h	e chang	ina:							
							nange To:			
,		SLU				SI	LUSB72B			
These changes may be reviewed at the datasheet links provided. <a href="http://www.ti.com/general/docs/lit/getliterature.tsp?genericPartNumber=ucd3138064&amp;fileType=pdf">http://www.ti.com/general/docs/lit/getliterature.tsp?genericPartNumber=ucd3138064&amp;fileType=pdf</a>										
<b>Reason for Chan</b>	ge:									
Die rev for product standardization.	t performa	ance. Mo	ount Co	omp	ound change fo	r As	sembly M	lateria	als	
Anticipated impa	act on Fo	rm, Fit,	Functi	ion,	<b>Quality or Re</b>	liabi	ility (pos	sitive	/ negative):	
None										

## Changes to product identification resulting from this PCN: Sample product shipping label (not actual product label) TEXAS INSTRUMENTS (1P) SN74LS07NSR MADE IN: Malaysia 2DC: 2Q: (Q) 2000 (D) 0336 (31T)LOT: 3959047MLA (4W) TKY(1T) 7523483SI2 MSL 2 /260C/1 YEAR SEAL DT MSL 1 /235C/UNLIM 03/29/04 OPT: ITEM: (21L) 0033317 (21L) CCO:USA (2P) REV: (20L) CSO: SHE (21L) CCO:USA (22L) ASO: MLA (23L) ACO: MYS (L)T0:1750 LBL: Die Rev Marking: Current= A3 New= A

UCD3138064RGZR

UCD3138064RGZT

Reference Qualification Data: Approved September 2014							
This qualification has been specifically developed for the validation of this change. The qualification data							
validates that the proposed change meets the applicable released technical specifications.							
Qualification Device: UCD3138064RGC (MSL3-260C)							
Package Construction Details							
Assembly Site:	Clark A/T	Mold Compound:	4208625				
# Pins-Designator, Family:	64-RGC, VQFN	Mount Compound:	4207123				
Lead Finish:	NiPdAu	Bond Wire:	0.96 Mil Dia., Au				
Qualification:  Plan  Test Results							
Reliability Test	Conditions	Sample Size / Fail					
Electrical Characterization	Full Temperature	Pass					
**T/C -65C/150C	-65C/+150C (500	77/0					
Notes: **Tests require preconditioning sequence: MSL3-260C							

UCD3138064RMHR

For questions regarding this notice, e-mails can be sent to the regional contacts shown below or your local Field Sales Representative.

Location	E-Mail
USA	PCNAmericasContact@list.ti.com
Europe	PCNEuropeContact@list.ti.com
Asia Pacific	PCNAsiaContact@list.ti.com
Japan	PCNJapanContact@list.ti.com

Product Affected:
UCD3138064RGCR

UCD3138064RGCT

UCD3138064RMHT